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| Notice of References Cited | Application/Control No. 10/607,129 | Applicant(s)/Patent Under Reexamination IWAGO ET AL. | |
| | Examiner Dave A. Ghatt | Art Unit 2854 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-2004/0081495 A1 | 04-2004 | Nakamura, Fumihiko | 399/367 |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
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FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | Q | | | | | |
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NON-PATENT DOCUMENTS

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| | V | |
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